

Description

The DMC3016LNS-7 uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = 30V I_{D} = 16 A$

 $R_{DS(ON)} < 20m\Omega$ @ $V_{GS}=10V$

 $V_{DS} = -30V I_{D} = -14A$

 $R_{DS(ON)} < 30 m\Omega$ @ $V_{GS}=10V$

Application

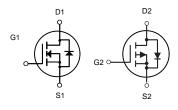
Battery protection

Load switch

Uninterruptible power supply

Pin 1 DFN3X3B-8L





N-Channel

P-Channel

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
DMC3016LNS-7	DFN3X3B-8L(PowerDI3333-8)	HXY MOSFET	5000

Absolute Maximum Ratings (T_C=25°C unless otherwise noted)

		Rating		
Symbol	Parameter	N-Channel	P-Channel	Units
V _{DS}	Drain-Source Voltage	30	-30	V
Vgs	Gate-Source Voltage	±20	±20	V
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ 10V ¹	16	-14	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	5	-4	А
Ідм	Pulsed Drain Current ²	40	-40	А
EAS	Single Pulse Avalanche Energy ³	26.6	110	mJ
las	Avalanche Current	8.7	- 20	Α
P _D @T _C =25°C	Total Power Dissipation ⁴	10.8	10.8	W
Тѕтс	Storage Temperature Range	-55 to 150	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	-55 to 150	°C
RθJA	Thermal Resistance Junction-Ambient ¹		62	°C/W
R _θ Jc	Thermal Resistance Junction-Case ¹		6	°C/W



N-Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
$\triangle BV_{DSS}/\triangle T$	BVDSS Temperature Coefficient	Reference to 25°C , I _D =1mA		0.023		V/°C
В	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =10A		14	20	m()
R _{DS(ON)}	Static Dialii-Source Off-Resistance	V _{GS} =4.5V , I _D =6A		20	25	mΩ
$V_{GS(th)}$	Gate Threshold Voltage		1.0		2.5	٧
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS, ID-250UA		-4.2		mV/°C
	Drain Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	$V_{GS} = \pm 20V$, $V_{DS} = 0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =10A		14		S
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		2.3		Ω
Qg	Total Gate Charge (4.5V)			5		
Q_{gs}	Gate-Source Charge	V _{DS} =20V , V _{GS} =4.5V , I _D =10A		1.11		nC
Q_{gd}	Gate-Drain Charge			2.61		
T _{d(on)}	Turn-On Delay Time			7.7		
T _r	Rise Time	V_{DD} =12V , V_{GS} =10V , R_{G} =3.3 Ω		46		
T _{d(off)}	Turn-Off Delay Time	I _D =6A		11		ns
T _f	Fall Time			3.6		
C _{iss}	Input Capacitance			416		
C _{oss}	Output Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		62		pF
C _{rss}	Reverse Transfer Capacitance			51		
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			16	Α
I _{SM}	Pulsed Source Current ^{2,5}	vg-vp-ov , i orde Gurrent			30	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1.2	V

Note:

^{1.} The data tested by surface mounted on a 1 inch 2 FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width \leqq 300us , duty cycle \leqq 2%

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH,I_{AS}=12.7A

^{4.} The power dissipation is limited by 150°C junction temperature

^{5.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



P-Channel Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V
$\triangle BV_{DSS}/\!\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.021		V/°C
В	Static Dunin Course On Besistance?	V _{GS} =-10V , I _D =-8A		25	30	0
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-4.5V , I _D =-6A		30	35	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} . In =-250uA	-1.0		-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID250UA		-4.2		mV/°C
	Dunin Course Lookers Courset	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			1	
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =55°C			5	uA
I _{GSS}	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-8A		12.6		S
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		15		Ω
Qg	Total Gate Charge (-4.5V)			9.8		
Q _{gs}	Gate-Source Charge	V_{DS} =-20V , V_{GS} =-4.5V , I_{D} =-6A		2.2		nC
Q_{gd}	Gate-Drain Charge			3.4		
T _{d(on)}	Turn-On Delay Time			16.4		
Tr	Rise Time	V_{DD} =-24V , V_{GS} =-10V , R_{G} =3.3 Ω ,		20.2		
T _{d(off)}	Turn-Off Delay Time	I _D =-1A		55		ns
T _f	Fall Time			10		
C _{iss}	Input Capacitance			930		
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		148		pF
C _{rss}	Reverse Transfer Capacitance			115		
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			-14	Α
I _{SM}	Pulsed Source Current ^{2,5}	vg-vp-ov , i oloc ouncill			-24	Α
V_{SD}	Diode Forward Voltage ²	V_{GS} =0 V , I_{S} =-1 A , T_{J} =25 $^{\circ}$ C			-1.2	V

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper. 2. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-30A
- 4.The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications , should be limited by total power dissipation.



N-Channel Typical Characteristics

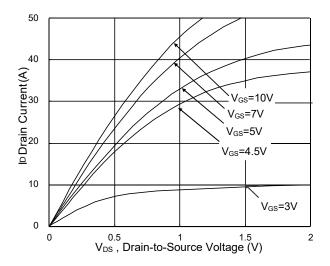


Fig.1 Typical Output Characteristics

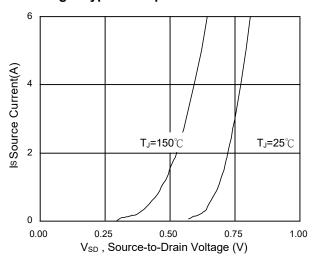


Fig.3 Forward Characteristics Of Reverse

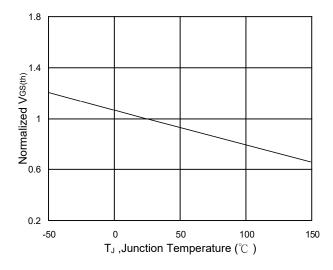


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_{J}

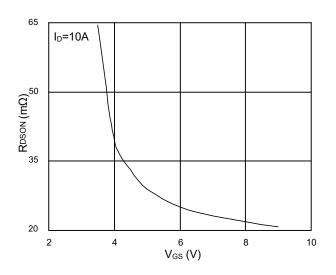


Fig.2 On-Resistance vs. Gate-Source

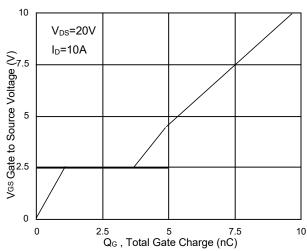


Fig.4 Gate-Charge Characteristics

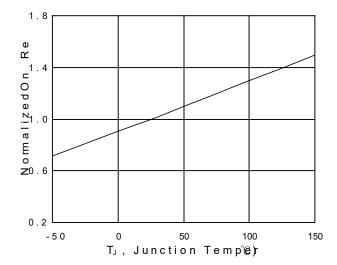
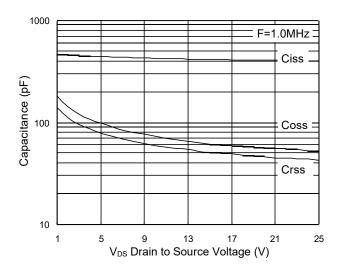


Fig.6 Normalized R_{DSON} vs. T_J





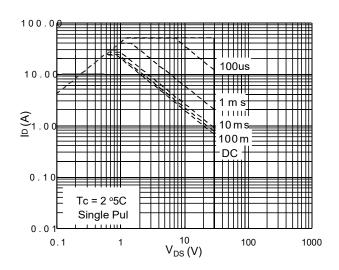
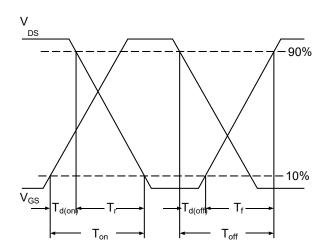
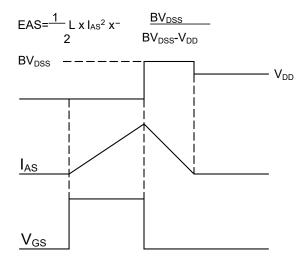


Fig.7 Capacitance Fig.8 Safe Operating Area Normalized Thermal Response (Reuc) DUTY=0.5 0.2 0.05 Ø.02 $T_{Jpeak} = T_C + P_{DM}XR_{\theta JC}$ SINGLE 10 0.00001 0.0001 0.001 0.01 0.1 t, Pulse Width (s)

Fig.9 Normalized Maximum Transient Thermal Impedance







P-Channel Typical Characteristics

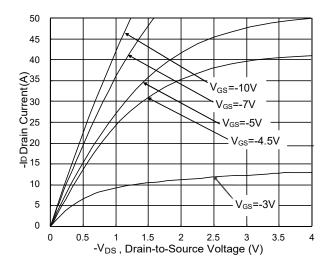


Fig.1 Typical Output Characteristics

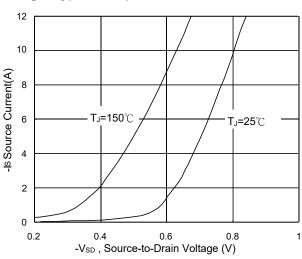


Fig.3 Forward Characteristics Of Reverse

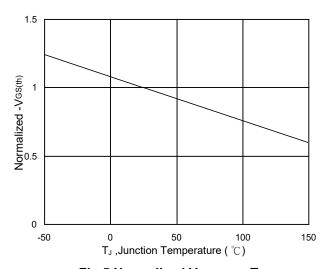


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

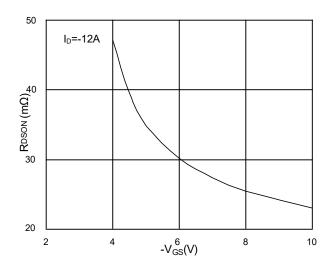


Fig.2 On-Resistance v.s Gate-Source

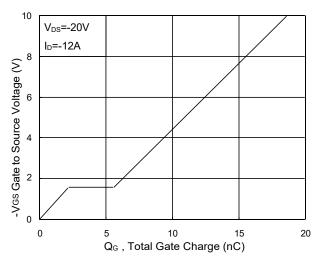


Fig.4 Gate-Charge Characteristics

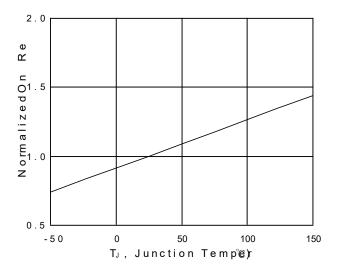
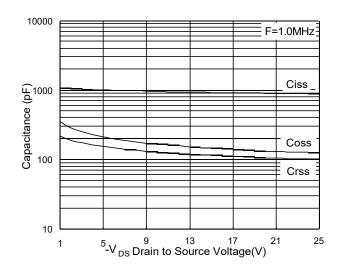


Fig.6 Normalized R_{DSON} v.s T_J





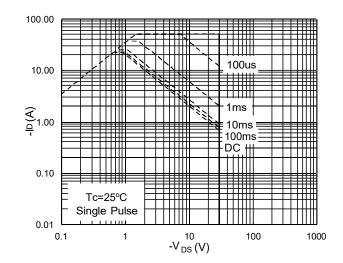


Fig.7 Capacitance

Fig.8 Safe Operating Area

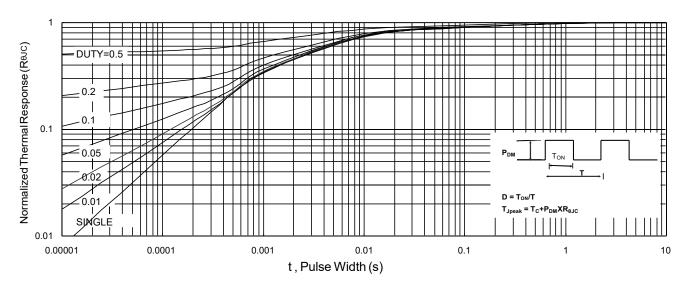
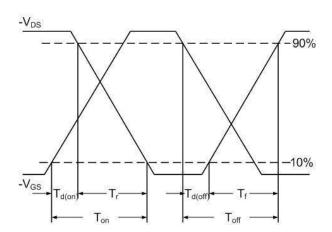
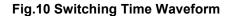


Fig.9 Normalized Maximum Transient Thermal Impedance





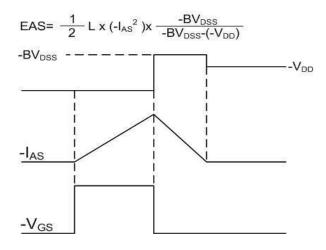
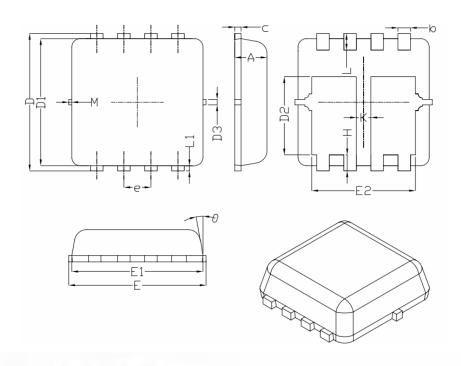


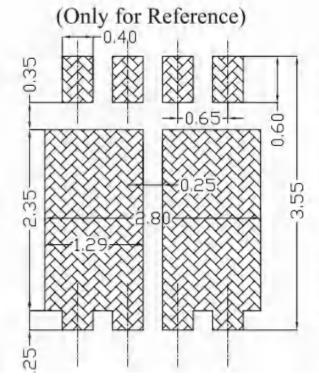
Fig.11 Unclamped Inductive Switching Waveform



DFN3X3B-8L(PowerDI3333-8) Package Information



Land Pattern



SYMBOL	DIMENS	ONAL RE	OMTS	
	MIN	NOM	MAX	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
C	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.78	1.88	1.98	
D3	***	0.13		
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
e	0.65BSC			
H	0.30	0.39	0.50	
L	0.30	0.40	0.50	
Ll		0.13		
K	0.30		-	
θ		10°	120	
M	Op-	*	0.15	
* No	specified			

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